Principal Component Analysis

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- Alternative name: Karhunene Loeve transform
- Used for: data approximation, identifying sources of variance in the data

Let the data be $\{\mathbf{x}_i \mid i = 1, 2, ..., N\}$, with sample mean $\overline{\mathbf{x}} = \frac{1}{N} \sum_{n=1}^{N} \mathbf{x}_n$.

Let us find the unit vector \mathbf{u}_1 to project to such that the variance $J(\mathbf{u}_1)$ of the projected data is *maximized*. The projection $\mathbf{x}_n^{(p)}$ of an \mathbf{x}_n to one-dimensional subspace generated by \mathbf{u}_1 is given by

$$\mathbf{x}_n^{(p)} = \mathbf{u}_1 \left(\mathbf{u}_1^{\mathrm{T}} \mathbf{x}_n \right), \quad \mathbf{u}_1^{\mathrm{T}} \mathbf{u}_1 = 1.$$
 (1)

The variance $J(\mathbf{u}_1)$ of projected data is

$$J(\mathbf{u}_1) = \frac{1}{N} \sum_{n=1}^{N} \left(\mathbf{u}_1^{\mathrm{T}} \mathbf{x}_n - \mathbf{u}_1^{\mathrm{T}} \overline{\mathbf{x}} \right)^2 = \frac{1}{N} \sum_{n=1}^{N} \mathbf{u}_1^{\mathrm{T}} (\mathbf{x}_n - \overline{\mathbf{x}}) (\mathbf{x}_n - \overline{\mathbf{x}})^{\mathrm{T}} \mathbf{u}_1 = \mathbf{u}_1^{\mathrm{T}} \mathbf{S} \mathbf{u}_1, \quad (2)$$

where ${\bf S}$ is the normalized scatter matrix:

$$\mathbf{S} = \frac{1}{N} \sum_{n=1}^{N} (\mathbf{x}_n - \overline{\mathbf{x}}) (\mathbf{x}_n - \overline{\mathbf{x}})^{\mathrm{T}}.$$
 (3)

The Lagrangian of this optimization problem is

$$L(\mathbf{u}_1, \lambda_1) = J(\mathbf{u}_1) + \lambda_1 \underbrace{(1 - \mathbf{u}_1^{\mathrm{T}} \mathbf{u}_1)}_{\text{constraint}} = \mathbf{u}_1^{\mathrm{T}} \mathbf{S} \mathbf{u}_1 + \lambda_1 (1 - \mathbf{u}_1^{\mathrm{T}} \mathbf{u}_1), \qquad (4)$$

where λ_1 is the Lagrange multiplier. Taking the derivative w.r.t. the vector ${\bf u}_1$ and setting it to zero gives

$$\frac{\partial L(\mathbf{u}_1, \lambda_1)}{\partial \mathbf{u}_1} = \mathbf{S}\mathbf{u}_1 - \lambda_1 \mathbf{u}_1 = 0,$$

and thus

$$\mathbf{Su}_1 = \lambda_1 \mathbf{u}_1 \,. \tag{6}$$

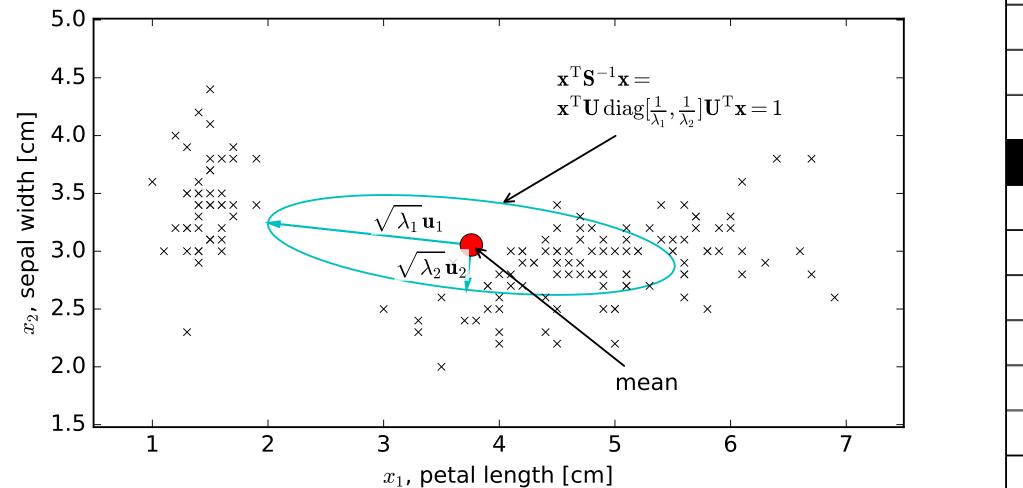
This is the characteristic equation for the covariance matrix **S**. Any eigenvalue λ_1 and its corresponding eigenvector \mathbf{v}_1 solves this equation, with variance $J(\mathbf{u}_1)$ equal to:

$$J(\mathbf{u}_1) = \mathbf{u}_1^{\mathrm{T}} \mathbf{S} \mathbf{u}_1 = \mathbf{u}_1^{\mathrm{T}} \lambda_1 \mathbf{u}_1 = \lambda_1 \,.$$
(7)

The maximum is attained if λ_1 is the largest eigenvalue of the matrix S and u_1 is its corresponding eigenvector.

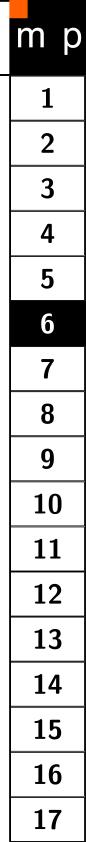
(5)

Example 1 - Iris dataset



Data shown as crosses \times . Iris dataset: feature vectors are 4-dimensional, here dimensions 2 and 3 used (petal length and sepal width).

Eigenvalues: $\lambda_1 = 3.148$, $\lambda_2 = 0.153$, eigenvectors $\mathbf{U} = [\mathbf{u}_1, \mathbf{u}_2]$. Variance is maximized when data are projected to direction \mathbf{u}_1 .



(8)

Recall: The variance of a 1-D projection is maximized when data are projected to the direction of the eigenvector of ${\bf S}$ corresponding to the largest eigenvalue.

 ${f S}$ is symmetric and positive semidefinite. The eigenvectors corresponding to different eigenvalues are orthogonal.

It follows that the D-dimensional subspace maximizing the variance of the data is the one formed by D eigenvectors of S corresponding the the D largest eigenvalues.

Note: "Variance" in the above sentence is the sum of variances in individual orthogonal directions. For a 2-D subspace,

$$J(\mathbf{u}_1, \mathbf{u}_2) = \frac{1}{N} \sum_{n=1}^{N} [\mathbf{u}_1^{\mathrm{T}}(\mathbf{x}_n - \overline{\mathbf{x}})]^2 + [\mathbf{u}_2^{\mathrm{T}}(\mathbf{x}_n - \overline{\mathbf{x}})]^2.$$

Consider the complete orthogonal basis $\{\mathbf{u}_i\}$ where $i = 1, \ldots, D$. Thus

$$\mathbf{u}_i^{\mathrm{T}}\mathbf{u}_j = \delta_{ij}$$

Each point can be represented as

$$\mathbf{x}_n = \sum_{i=1}^D \alpha_{ni} \mathbf{u}_i \,, \tag{10}$$

 and

$$\mathbf{x}_n = \sum_{i=1}^D (\mathbf{x}_n^{\mathrm{T}} \mathbf{u}_i) \mathbf{u}_i \,. \tag{11}$$

This is just expressing \mathbf{x}_n in a rotated coordinate system given by orthonormal system $\{\mathbf{u}_i\}$. Let us create an approximation to each \mathbf{x}_n by truncating this expansion to only M components, the remaining D - M components approximated by constants b_i . The approximation $\tilde{\mathbf{x}}_n$:

$$\tilde{\mathbf{x}}_n = \sum_{i=1}^M (\mathbf{x}_n^{\mathrm{T}} \mathbf{u}_i) \mathbf{u}_i + \sum_{i=M+1}^D b_i \mathbf{u}_i$$
(12)

(9)

Equivalence to Minimum error formulation (2/2)

$$\tilde{\mathbf{x}}_n = \sum_{i=1}^M (\mathbf{x}_n^{\mathrm{T}} \mathbf{u}_i) \mathbf{u}_i + \sum_{i=M+1}^D b_i \mathbf{u}_i$$

Clearly,

$$b_i = \overline{\mathbf{x}}^{\mathrm{T}} \mathbf{u}_i, i = M + 1, \dots, D$$

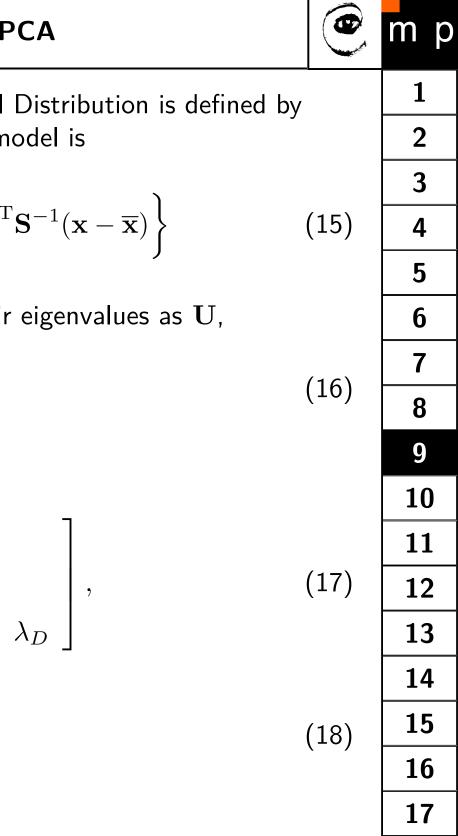
The task is to find the optimal orthonormal basis $\{\mathbf{u}_i\}$ which produces the best approximation measured by

$$J({\mathbf{u}_i}) = \frac{1}{N} \sum_{n=1}^N \|\mathbf{x}_n - \tilde{\mathbf{x}}_n\|^2$$
(14)

The minimum error criterion is the complement of the maximum variance criterion, and thus the solution to the set $\{u_i\}$ is the same.

(12)

(13)



Recall that the ML estimate of the Multivariate Normal Distribution is defined by sample mean \overline{x} and sample covariance matrix S. The model is

$$p(\mathbf{x} \mid \overline{\mathbf{x}}, \mathbf{S}) = \frac{1}{\sqrt{|2\pi\mathbf{S}|}} \exp\left\{-\frac{1}{2}(\mathbf{x} - \overline{\mathbf{x}})^{\mathrm{T}}\mathbf{S}^{-1}(\mathbf{x} - \overline{\mathbf{x}})\right\}$$

Denote stacked eigenvectors in descending order of their eigenvalues as $\mathbf{U},$

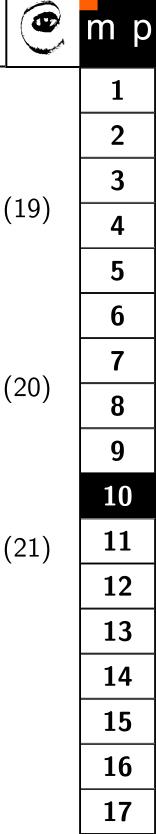
$$\mathbf{U} = \{\mathbf{u}_1, \mathbf{u}_2, ..., \mathbf{u}_D\}$$

Therefore (characteristic equation)

$$\mathbf{SU} = \mathbf{U} \mathbf{\Lambda} = \mathbf{U} \begin{bmatrix} \lambda_1 & & & \\ & \lambda_2 & & \\ & & \ddots & \\ & & & \lambda_D \end{bmatrix},$$

 $\mathbf{S} = \mathbf{U} \mathbf{\Lambda} \mathbf{U}^{\mathrm{T}}$.

and



We approximate the data, as before, by projecting to first M eigenvectors. Thus, given data point ${\bf x}$ we have

$$\mathbf{x} - \overline{\mathbf{x}} = (\delta_1, \delta_2, ..., \delta_M, \delta_{M+1}, ..., \delta_D)$$
(19)

Note that we only can compute $\delta_1 \dots \delta_M$, as often we don't or can't store all eigenvectors for computing all δ 's. However, we can easily compute

$$\Delta = \delta_{M+1}^2 + \delta_{M+2}^2 + \dots + \delta_D^2 = \|\mathbf{x} - \overline{\mathbf{x}}\|^2 - \delta_1^2 - \delta_2^2 - \dots - \delta_M^2$$

and the exponent is then approximated as

$$-\frac{1}{2}(\mathbf{x}-\overline{\mathbf{x}})^{\mathrm{T}}\mathbf{S}^{-1}(\mathbf{x}-\overline{\mathbf{x}}) \simeq -\frac{1}{2}\left(\frac{\delta_{1}^{2}}{\lambda_{1}} + \frac{\delta_{2}^{2}}{\lambda_{2}} + \frac{\delta_{3}^{2}}{\lambda_{3}} + \dots \frac{\delta_{M}^{2}}{\lambda_{M}} + \frac{\Delta}{\lambda}\right)$$

Common choice: $\lambda = \lambda_{M+1}$

Dimensionality of data can be high, and even higher than number of samples.

Consider dimensionality D = 1M (one million) and number of samples N = 100. All analysis still applies, but it would be wasteful to compute eigenvectors for the 1M×1M matrix, as its rank will anyway be at most N (thus 100). Let us define \mathbf{X} to be a matrix formed by stacking all the data vectors (after having subtracted the mean from them): $\mathbf{X} = [\mathbf{x}_1 - \overline{\mathbf{x}}, \mathbf{x}_2 - \overline{\mathbf{x}}, ..., \mathbf{x}_N - \overline{\mathbf{x}}].$

Thus,

$$\mathbf{S} = \frac{1}{N} \sum_{n=1}^{N} (\mathbf{x}_n - \overline{\mathbf{x}}) (\mathbf{x}_n - \overline{\mathbf{x}})^{\mathrm{T}} = \frac{1}{N} \mathbf{X} \mathbf{X}^{\mathrm{T}}.$$

The characteristic equation is then

$$\frac{1}{N} \mathbf{X} \mathbf{X}^{\mathrm{T}} \mathbf{u} = \lambda \mathbf{u} \,. \tag{23}$$

Left-multiplying both sides by \mathbf{X}^{T} gives

$$\frac{1}{N} \mathbf{X}^{\mathrm{T}} \mathbf{X} \left(\mathbf{X}^{\mathrm{T}} \mathbf{u} \right) = \lambda \left(\mathbf{X}^{\mathrm{T}} \mathbf{u} \right) .$$
(24)

(22)

Thus, $\mathbf{X}^{\mathrm{T}}\mathbf{X}$, which is only 100×100 , has exactly the same set of eigenvalues:

$$\frac{1}{N} \mathbf{X}^{\mathrm{T}} \mathbf{X} \mathbf{w} = \lambda \mathbf{w} \,. \tag{25}$$

Left-multiplying now by $\mathbf{X},$ we get

$$\frac{1}{N} \mathbf{X} \mathbf{X}^{\mathrm{T}}(\mathbf{X} \mathbf{w}) = \lambda(\mathbf{X} \mathbf{w}).$$

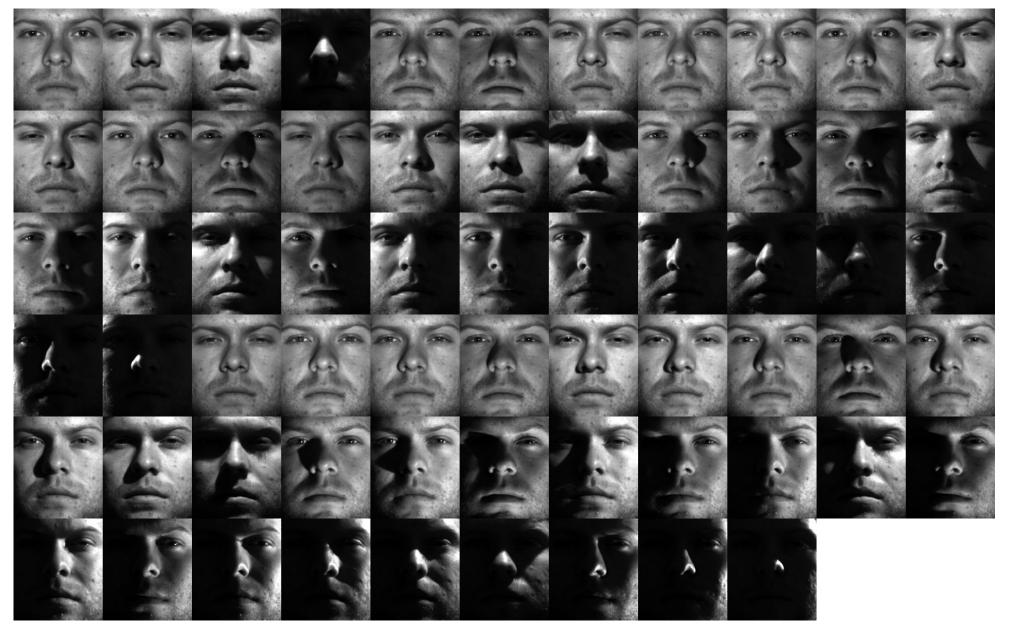
Conclusion: If $D \gg N$, form the matrix $\mathbf{T} = \frac{1}{N} \mathbf{X}^{\mathrm{T}} \mathbf{X}$ and compute its eigenvalues λ 's and eigenvectors \mathbf{w} . Compute the eigenvectors of $\mathbf{S} = \frac{1}{N} \mathbf{X} \mathbf{X}^{\mathrm{T}}$ as

$$\mathbf{v} = \frac{\mathbf{X}\mathbf{w}}{\|\mathbf{X}\mathbf{w}\|} \,. \tag{27}$$

Example 2 - Yale database (1/5)

m p

images of 38 subjects, each under 64 different illumination conditions:



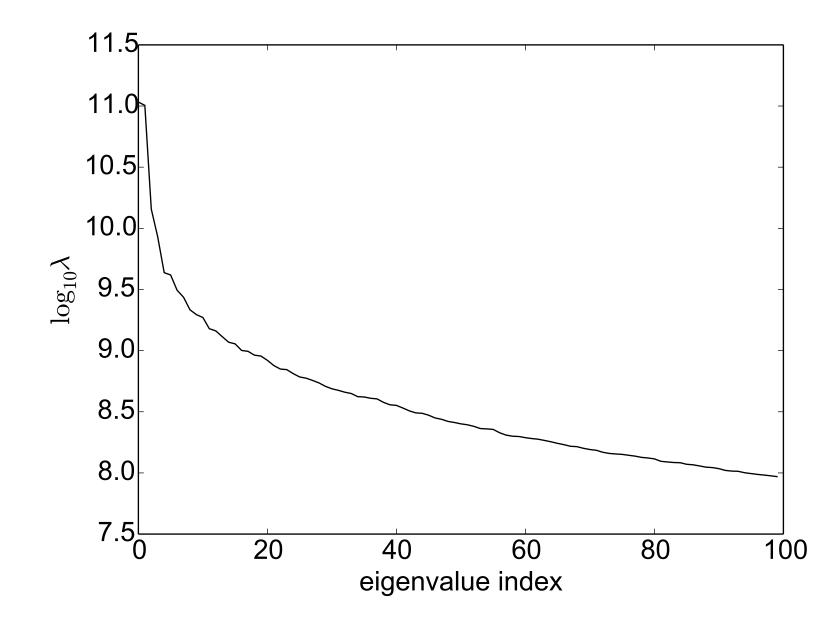
Subject 1, 64 illumination conditions

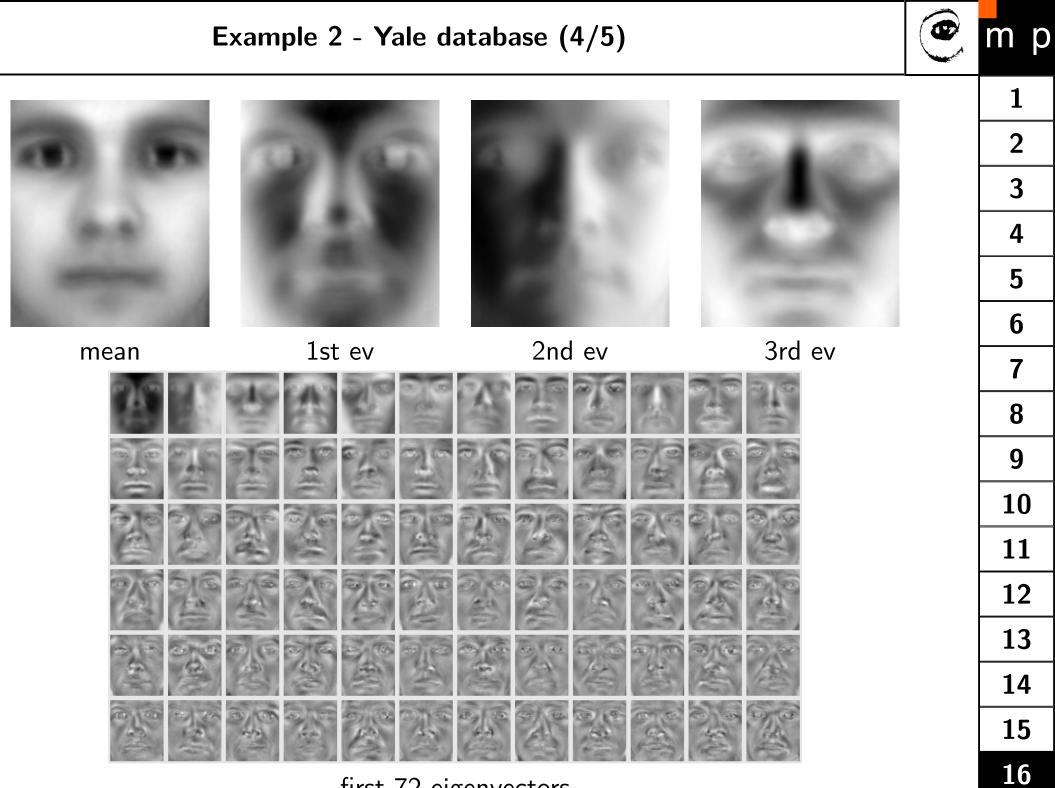
images of 38 subjects, each under 64 different illumination conditions:



38 subjects

images of 38 subjects, each under 64 different illumination conditions. Thus, there is $38 \times 64 = 2432$ images in total. Each of them is a feature vector with $192 \times 168 = 32256$ dimensions (pixels). PCA gives the following eigenvalues:





first 72 eigenvectors

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